

<b>Notice of References Cited</b>	Application/Control No. 10/510,136		Applicant(s)/Patent Under Reexamination KADOWAKI, YUKIO	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,817,182 A	03-1989	Adelson et al.	382/248
*	B	US-5,014,134 A	05-1991	Lawton et al.	382/240
*	C	US-5,471,207 A	11-1995	Zandi et al.	341/107
*	D	US-5,659,631 A	08-1997	Gormish et al.	382/166
*	E	US-5,793,892 A	08-1998	Pan et al.	382/232
*	F	US-5,881,173 A	03-1999	Ohmori, Masatake	382/232
*	G	US-6,215,421 B1	04-2001	Kondo et al.	341/50
*	H	US-6,462,681 B1	10-2002	Van Der Vleuten et al.	341/50
*	I	US-6,947,484 B2	09-2005	Inagaki et al.	375/240.02
*	J	US-7,020,342 B1	03-2006	Kleihorst et al.	382/250
*	K	US-7,212,677 B2	05-2007	Mishima, Nobuhiro	382/237
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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